Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | LEE ET AL. | Examiner | Art Unit | Tom V. Sheng | 2677 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,236,384 B1	05-2001	Didier et al.	345/87
*	В	US-2002/0097206 A1	07-2002	Willis, Donald Henry	345/87
*	С	US-6,388,967 B2	05-2002	Furukawa et al.	369/53.19
*	D	US-6,346,903 B1	02-2002	Messager, Philippe	341/154
*	Е	US-5,940,055	08-1999	Lee, Gyu-Su	345/87
*	F	US-5,534,889	07-1996	Reents et al.	345/89
*	G	US-5,561,442	10-1996	Okada et al.	345/94
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	1	US-			
	J	US-			
	К	US-			
	L	US-		·	
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.